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Application/Control No.	Applicant(s)/Patent under Reexamination
10/627,867	HANNULA ET AL.
Examiner	Art Unit
Jacqueline Cheng	3768

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Class	Subclass	Date	Examiner
600	414	2/8/2007	JC
	417	2/8/2007	JC
	426	2/8/2007	JC
	429	2/8/2007	JC .
606	130	2/27/2007	JC
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